



17. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMJ330F	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT		Approved by: Quality Manager
Filename: 1M1704170148-10.A3L	Test Dates: 04/17/2017 - 04/21/2017	DUT Type: Portable Handset	Page 63 of 65	

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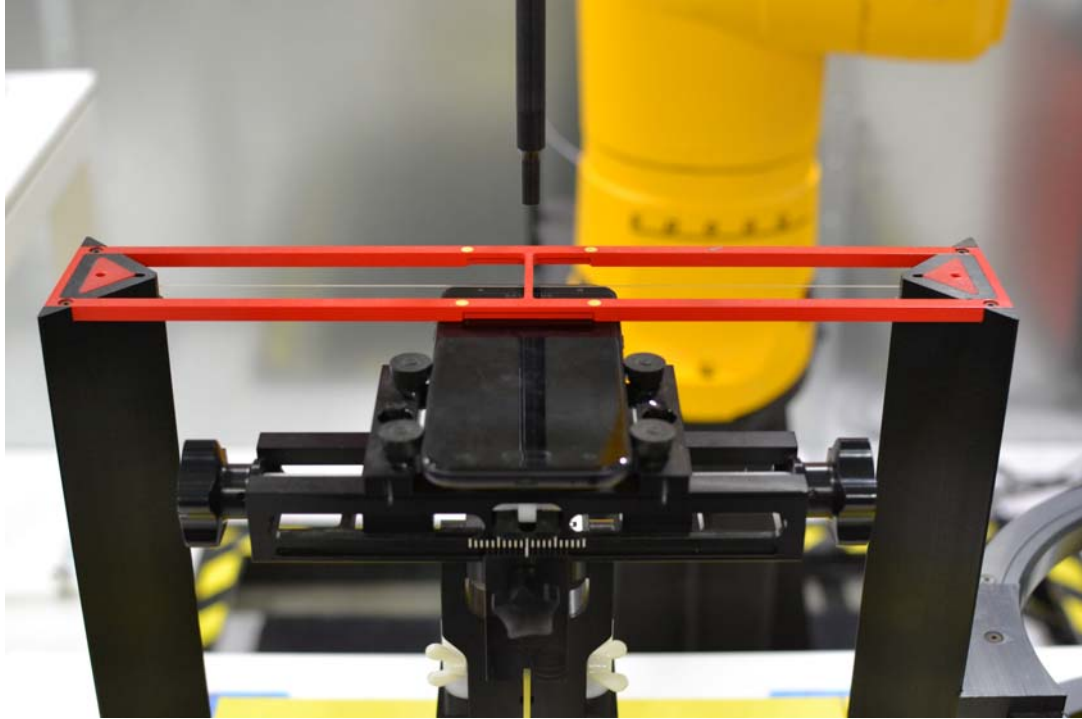


Figure 17-1
Ear Reference Point HAC Phantom Alignment

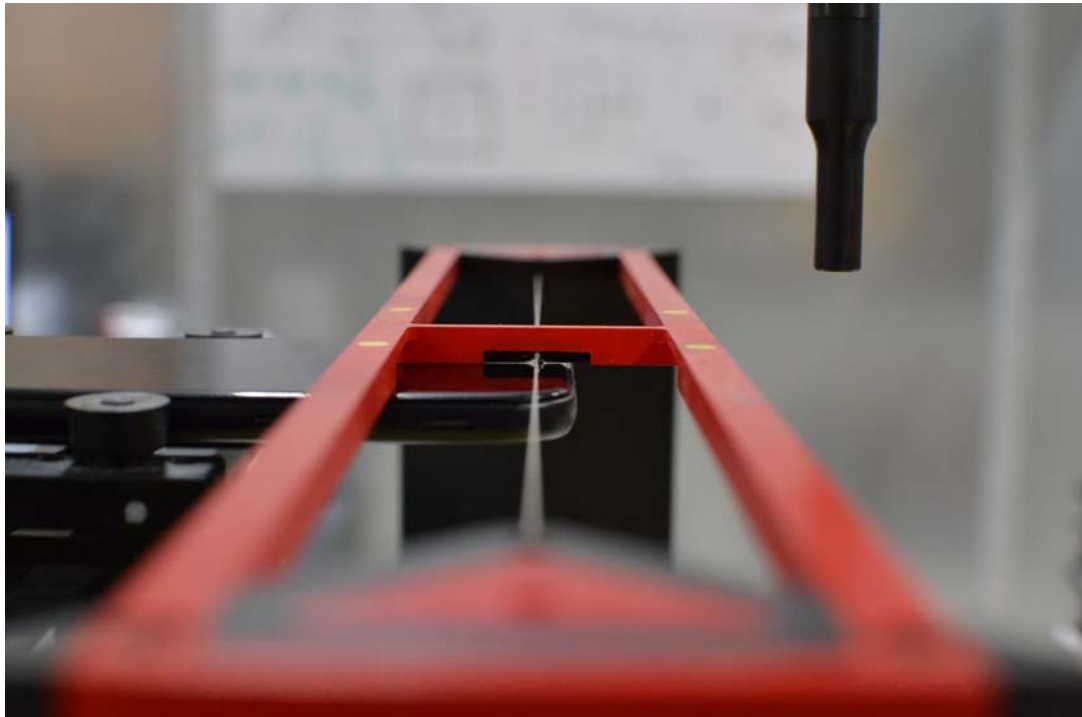




Figure 17-2
HAC Phantom Plane Alignment

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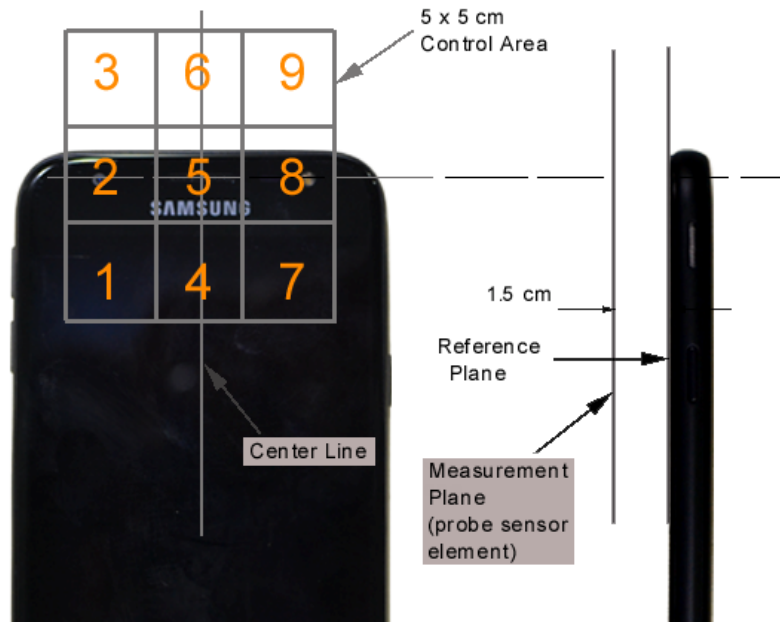




Figure 17-3 5x5 Scan grid above WD



Figure 17-4 E-Field WD Scan overlay

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